

**Search Notes**

Application/Control No.

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

TSURUYA, TAKAAKI

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	232-235, 248-250	2/20/2006	HP
250	234	2/20/2006	HP
358	1.9	2/20/2006	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	2/20/2006	HP